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otes	Application/Control No.	Applicant(s)/Patent under Reexamination	•
	10/759,207	CHAN ET AL.	
	Examiner	Art Unit	•
	Christy L. Novacek	2822	

SEARCHED			
Class	Subclass	Date	Examiner
438	424	8/4/2005	CN
438	425	8/4/2005	CN
438	435	8/4/2005	CN
· 438	437	8/4/2005	CN
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST Search USPGPUB USPAT EPO JPO	8/4/2005	CN
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